

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10596782	SCHLIWA-BERTLING ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	WEI ZHAO	2475

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
370	229, 412, 235	6/15, 12/8, 7/25/2011	WZ
714	748	6/15, 7/25/2011	WZ

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Searched using US-PGPUB, USPAT, DERWENT, IBM_TDB in EAST	6/15, 7/25/2011	WZ
Did double patenting search and inventorship search for ODP in Palm Resource Center	6/15, 7/25/2011	WZ

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
370	412	6/15, 7/25/2011	WZ

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